

Search Notes

Application/Control No.

10/725,132

Examiner

Len Tran

Applicant(s)/Patent under
Reexamination

ONISHI

Art Unit

1725

SEARCHED

Class	Subclass	Date	Examiner
219	109	3/6/2005	LT
	86.9		
	56.22		
	56.21		
	56.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST and Palm	3/6/2005	LT